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 Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,939	NARIYUKI, FUMITO	
Examiner	Art Unit	
Thorl Chea	1752	

	SEARCHED			
Class	Subclass	Date	Examiner	
430	350;619 567;945 264;607 613	3/30/2005	тсн	
To date	the above	10/5/2005	тсн	
To date	the above	5/5/2006	тсн	
To date	the above	1/25/2007	тсн	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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